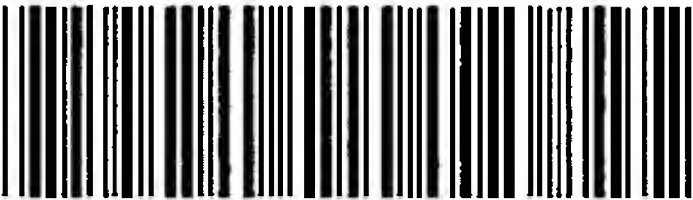


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/605,937	BIEL, MICHAEL J.	
	Examiner	Art Unit	
	Noah Kamen	3747	

SEARCHED			
Class	Subclass	Date	Examiner
search	updated	8/29/2005	NK

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR